Few-view, High Resolution Inspection

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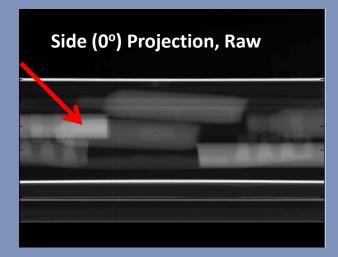
ADSA 11 November 5, 2014

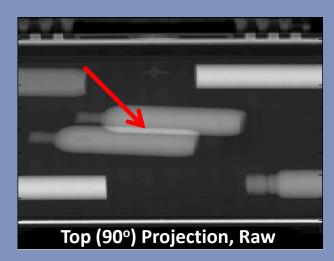
Acknowledgements

- Data provided by ALERT via Task Order 3
- JF summer support provided by AS&E gift to ALERT



Problem: 1) Obscured objects 2) Few-view* systems





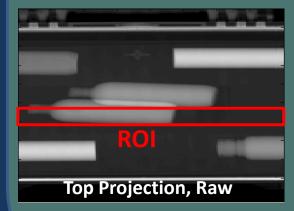
* too many views for easy manual review, but too few for high-res 3D recon

Solution: use coarse 3-D recon to highlight ROI in projection data

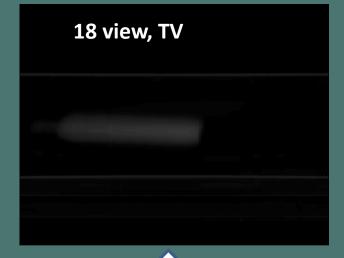
1) Form coarse 3D recon



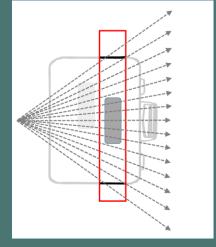
2) Identify / scan through Regions of Interest



4) Side projection, ROI highlighted

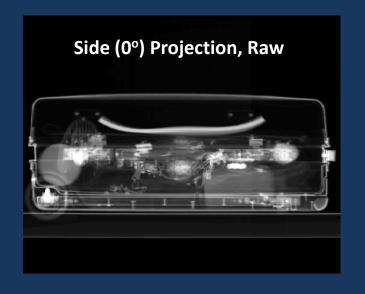


3) Do ROI-based processing

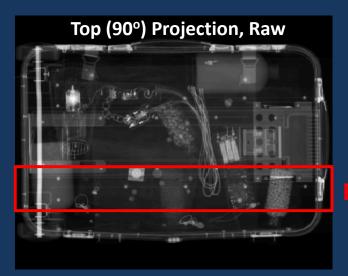


y' = f(y,ROI, x) y = projection, x = recon

Medium Clutter Dataset











Ongoing work:

- Investigate different recon methods and strategies for ROI based processing
- Understand how results depend on system geometry (# views, spacing)

Questions?